

Issue Classification				Application/Control No.			Applicant(s)/Patent under Reexamination	
				10/640,082			LEE, CHANG-HYUN	
				Examiner Tan T. Nguyen			Art Unit 2827	

ISSUE CLASSIFICATION								
ORIGINAL		CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
365	185.170	365	185.18 0	185.23 0	185.28 0			
INTERNATIONAL CLASSIFICATION								
G	1	1	C	16/00				
				/				
				/				
				/				
				/				
					TAN T. NGUYEN PRIMARY EXAMINER GROUP 2800 Tan T. Nguyen <i>[Signature]</i> (Primary Examiner)	Total Claims Allowed: 82 <i>06/07/05</i> (Date)		
Assistant Examiner) (Date) <i>[Signature]</i> (Legal Instruments Examiner) (Date)					O.G. Print Claim(s) 27	O.G. Print Fig 4		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	31	31	66	61	91	121
2	2	32	32	67	62	92	122
3	3	33	33	63	63	93	123
4	4	34	34	64	64	94	124
5	5	35	35	65	65	95	125
6	6	36	36	68	66	96	126
7	7	37	37	70	67	97	127
8	8	40	38	71	68	98	128
9	9	51	39	69	69	99	129
10	10	52	40	72	70	100	130
11	11	41	41	78	71	101	131
12	12	42	42	79	72	102	132
14	13	43	43	73	73	103	133
15	14	44	44	74	74	104	134
16	15	45	45	75	75	105	135
17	16	46	46	76	76	106	136
18	17	47	47	77	77	107	137
19	18	48	48	80	78	108	138
20	19	49	49	81	79	109	139
21	20	50	50	81	80	110	140
22	21	53	51	13	81	111	141
23	22	54	52	39	82	112	142
24	23	55	53		83	113	143
25	24	56	54		84	114	144
26	25	67	55		85	115	145
27	26	58	56		86	116	146
38	27	59	57		87	117	147
28	28	60	58		88	118	148
29	29	61	59		89	119	149
30	30	62	60		90	120	150
							180
							210